## Notice of References Cited Application/Control No. 09/942,408 Examiner John Pezzlo Applicant(s)/Patent Under Reexamination FURUKAWA ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	Α	US-2003/0037167 A1	02-2003	Garcia-Luna-Aceves et al.	709/238
A	В	US-6,393,012 B1	05-2002	Pankaj, Rajesh K.	370/342
X	С	US-5,987,011 A	11-1999	Toh, Chai Keong	370/331
	D	US-			
	Ε	US-			
	F	US-	-		
	G	US-			
	н	US-			
	I	US-			
	J	US-			
	κ	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	/z			1000		
	0					
	Р					
	Q					
	R					
	S					
	Т					

## NON-PATENT DOCUMENTS

		TOTAL TALLET DESCRICTED
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	x	

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